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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant:	Mladen Barbic	Examiner:	To be assigned
Serial No.:	10/849,764	Group Art Unit:	2878
Filed:	May 20, 2004	Docket:	G&C 176.19-US-U1
Title:	TWO-DIMENSIONAL MAGNETIC RESONANCE TOMOGRAPHIC MICROSCOPY		

CERTIFICATE OF MAILING OR TRANSMISSION UNDER 37 CFR 1.8

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By: 

Name: Jason S. Feldmar

MAIL STOP AMENDMENT

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Dear Sir:

We are transmitting herewith the attached:

- ☒ Transmittal sheet, in duplicate, containing a Certificate of Mailing under 37 CFR 1.8.
- ☒ Information Disclosure Statement and Form PTO-1449.
- ☒ Cited Reference(s).
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Howard Hughes Center  
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(310) 641-8797

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Name: Jason S. Feldmar

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(PTO TRANSMITTAL - GENERAL)



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**INFORMATION DISCLOSURE STATEMENT(37 C.F.R. §1.97(b))**

MAIL STOP AMENDMENT

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Dear Sir:

With regard to the above-identified application, the items of information listed on the enclosed Form 1449 are brought to the attention of the Examiner.

This statement should be considered because it is submitted before the mailing date of a first Office Action on-the-merits. Accordingly, no fee is due for consideration of the items listed on the enclosed Form 1449.

In accordance with 37 C.F.R. §1.98(a)(2), a copy of each foreign patent document and each non-patent document listed on the enclosed Form 1449 is provided.

No representation is made that a reference is "prior art" within the meaning of 35 U.S.C. §§ 102 and 103 and Applicants reserve the right, pursuant to 37 C.F.R. § 1.131 or otherwise, to

establish that the reference(s) are not "prior art". Moreover, Applicants do not represent that a reference has been thoroughly reviewed or that any relevance of any portion of a reference is intended.

Consideration of the items listed is respectfully requested. Pursuant to the provisions of M.P.E.P. 609, it is requested that the Examiner return a copy of the attached Form 1449, marked as being considered and initialed by the Examiner, to the undersigned with the next official communication.

Please direct any response or inquiry to the below-signed attorney at (310) 641-8797.

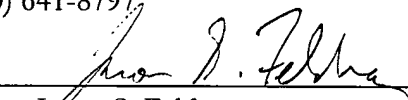
Respectfully submitted,

GATES & COOPER LLP  
Attorneys for Applicant(s)

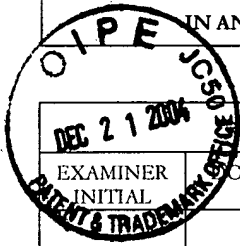
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U.S. PATENT DOCUMENTS							
EXAMINER INITIAL	DOCUMENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
FOREIGN PATENTS							
	DOCUMENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
NON-PATENT DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)							
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EXAMINER:				DATE CONSIDERED:			
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